SHEET 1 OF 2

Form PTO 1449		U.S. DEPARTMENT		ATTY DOCKET NO. 250213US2CONT		SERIAL NO. 10/810,831					
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LIST OF	REFE	RENCES CITED BY API	PLICANT	Katsuaki MIYAWAKI, et al.							
				FILING DATE		GROUP					
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	-	DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO					
1, 6	AO	S61-167655	10/17/1986	JAPAN (w/ English translation)							
8/6	AP	6-195007	07/15/1994	JAPAN (w/ English Abstract)							
820	AQ	5-323781	12/07/1993	JAPAN (w/ English Abstract)							
3	AR	1-166060	06/29/1989	JAPAN (w/ English Abstract)							
	AS	64-031173	01/02/1989	JAPAN (w/ English Abstract)			X				
	AT	2001-100488	04/13/2001	JAPAN (w/ English Abstract)							
	ΑU	5-100576	04/23/1993	JAPAN (w/ English Abstract)							
V	AV	2001-075449	03/23/2001	JAPAN (w/ English Abstract)							
X, 6	AW	11-38791	05/31/1989	JAPAN (w/ English Abstract)							
,		OTHER RE	FERENCES (I	ncluding Author, Title, Date, Pertinen	t Pages, et	c.)					
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		DOCUMENT DATE		COUNTRY		TRANSLATION YES NO					
26	AO	2000-221799	08/11/2000	JAPAN (w/ English Abstract)							
0	AP	5-212857	08/24/1993	JAPAN (w/ English Abstract)							
	AQ	10-039557	02/13/1998	JAPAN (w/ English Abstract)							
	AR	2001-75329	03/23/2001	JAPAN (w/ English Abstract)							
	AS	11-109706	04/23/1999	JAPAN (w/ English Abstract)		·					
	AT	7-261496	10/13/1995	JAPAN (w/ English Abstract)							
h	AU	2000-181142	06/30/2000	JAPAN (w/ English Abstract)							
5/2	AW	2000-3117 11-133696	01/07/2000 05/21/1999	JAPAN (w/ English Abstract) JAPAN (w/ English Abstract)	-						
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